



SUPER-SEMI



SUPER-MOSFET

Super Junction Metal Oxide Semiconductor Field Effect Transistor

650V Super Junction Power MOSFET Gen-II
SS*65R190S2E

Rev. 1.0
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SSF65R190S2E/SSP65R190S2E 650V N-Channel Super-Junction MOSFET Gen-II

Description

SJ-FET is new generation of high voltage MOSFET family that is utilizing an advanced charge balance mechanism for outstanding low on-resistance and lower gate charge performance. This advanced technology has been tailored to minimize conduction loss, provide superior switching performance, and withstand extreme dv/dt rate and higher avalanche energy. SJ-FET is suitable for various AC/DC power conversion in switching mode operation for higher efficiency.

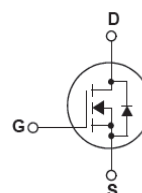
Features

- Multi-Epi process SJ-FET
- 700V @T_J = 150 °C
- Typ. RDS(on) = 150mΩ
- Ultra Low Gate Charge (typ. Qg = 31nC)
- 100% avalanche tested

SSF65R190S2E



SSP65R190S2E



Absolute Maximum Ratings

Symbol	Parameter	SSP65R190S2E		SSF65R190S2E	Unit
V _{DSS}	Drain-Source Voltage	650			V
I _D	Drain Current -Continuous (TC = 25°C)	20*			A
	-Continuous (TC = 100°C)	12.6*			
I _{DM}	Drain Current - Pulsed (Note 1)	60			A
V _{GSS}	Gate-Source voltage	±30			V
E _{AS}	Single Pulsed Avalanche Energy (Note 2)	540			mJ
I _{AS}	Avalanche current, repetitive or not-repetitive (pulse width limited by T _J max)	6			A
dv/dt	Peak Diode Recovery dv/dt (Note 3)	15			V/ns
dVds/dt	Drain Source voltage slope (V _{ds} =480V)	50			V/ns
P _D	Power Dissipation (TC = 25°C)	145		36	W
T _J , T _{STG}	Operating and Storage Temperature Range	-55 to +150			°C
T _L	Maximum Lead Temperature for Soldering Purpose, 1/16" from Case for 10 Seconds	260			°C

* Drain current limited by maximum junction temperature. Maximum duty cycle D=0.75

Thermal Characteristics

Symbol	Parameter	SSP65R190S2E		SSF65R190S2E	Unit
R _{θJC}	Thermal Resistance, Junction-to-Case	0.85		3.5	°C/W
R _{θCS}	Thermal Resistance, Case-to-Sink Typ.	0.5		-	°C/W
R _{θJA}	Thermal Resistance, Junction-to-Ambient	62		80	°C/W



Electrical Characteristics TC = 25°C unless otherwise noted

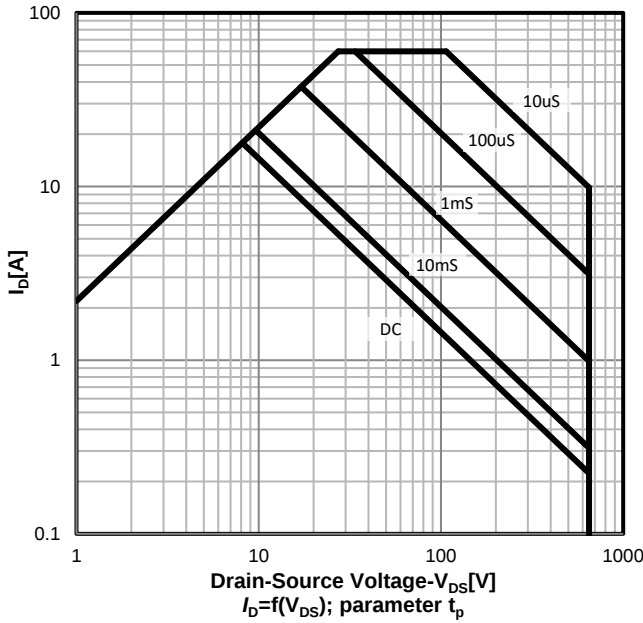
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Off Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0V, I _D = 1mA, T _J = 25°C	650	-	-	V
		V _{GS} = 0V, I _D = 1mA, T _J = 150°C	700	-	-	V
ΔBV _{DSS} /ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = 1mA, Referenced to 25°C	-	0.6	-	V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 650V, V _{GS} = 0V -T _J = 125°C	-	-	1 100	μA μA
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 30V, V _{DS} = 0V	-	-	100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -30V, V _{DS} = 0V	-	-	-100	nA
On Characteristics						
V _{GS(th)}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 800μA	2.5	3.5	4.5	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10V, I _D = 10A	-	150	190	mΩ
Dynamic Characteristics						
C _{iss}	Input Capacitance	V _{DS} = 100V, V _{GS} = 0V, f = 1.0MHz	-	1240	-	pF
C _{oss}	Output Capacitance		-	60	-	pF
C _{rss}	Reverse Transfer Capacitance		-	1	-	pF
Q _g	Total Gate Charge	V _{DS} = 400V, I _D = 10A, V _{GS} = 10V (Note 4)	-	31	-	nC
Q _{gs}	Gate-Source Charge		-	9.8	-	nC
Q _{gd}	Gate-Drain Charge		-	10.1	-	nC
V _{plateau}	Gate plateau voltage		-	5.8	-	V
R _g	Gate resistance		f=1 MHz, open drain	-	1.8	-
Switching Characteristics						
t _{d(on)}	Turn-On Delay Time	V _{DS} = 400V, I _D = 10A R _G = 10Ω, V _{GS} = 10V (Note 4)	-	12	-	ns
t _r	Turn-On Rise Time		-	8	-	ns
t _{d(off)}	Turn-Off Delay Time		-	53	-	ns
t _f	Turn-Off Fall Time		-	10	-	ns
Drain-Source Diode Characteristics and Maximum Ratings						
I _S	Maximum Continuous Drain-Source Diode Forward Current		-	-	20	A
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current		-	-	60	A
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0V, I _S = 20A	-	0.9	1.4	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0V, V _{DS} = 400V, I _S = 10A, dI _F /dt =100A/μs	-	320	-	ns
Q _{rr}	Reverse Recovery Charge		-	4.3	-	μC
I _{rrm}	Peak Reverse Recovery Current		-	27	-	A

NOTES:

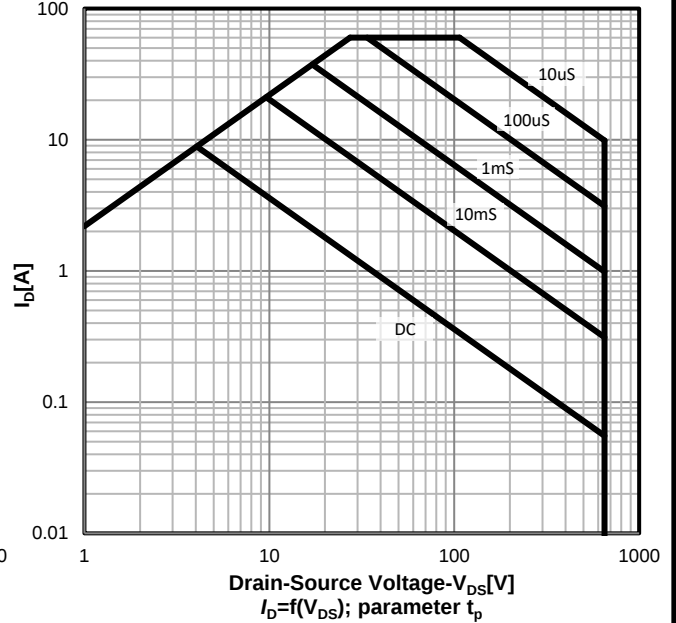
1. Repetitive Rating: Pulse width limited by maximum junction temperature
2. I_D=I_{AS}, V_{DD}=100V, L=30mH, Starting T_J=25 °C
3. I_{SD}≤I_D, di/dt ≤ 200A/μs, V_{DD} ≤ BV_{DSS}, Starting T_J = 25 °C
4. Essentially Independent of Operating Temperature Typical Characteristics

Typical Performance Characteristics

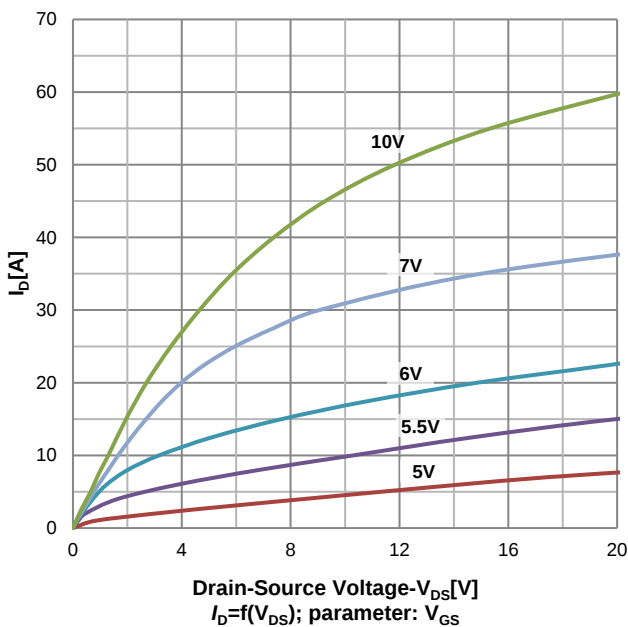
Safe operating area TC=25 °C
TO-220



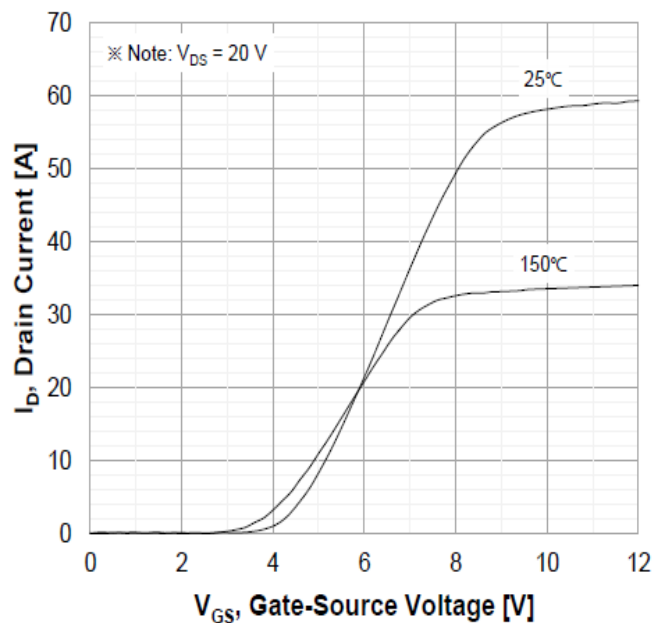
Safe operating area TC=25 °C
TO-220FullPAK



Typ. output characteristics $T_j=25$ °C

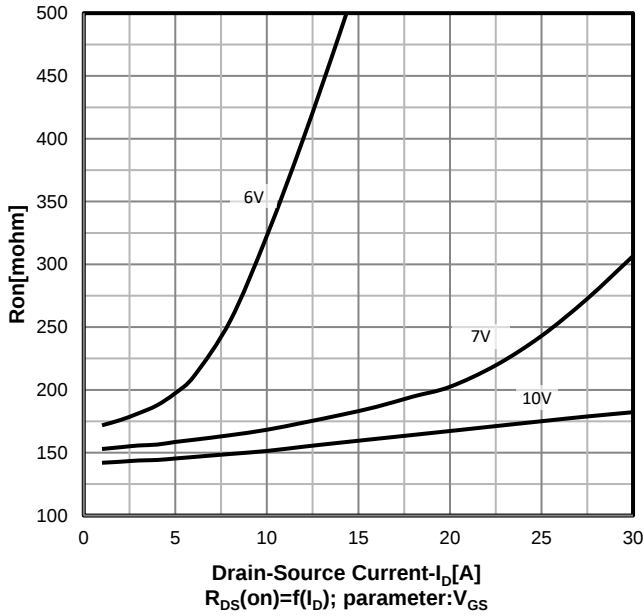


Transfer characteristics

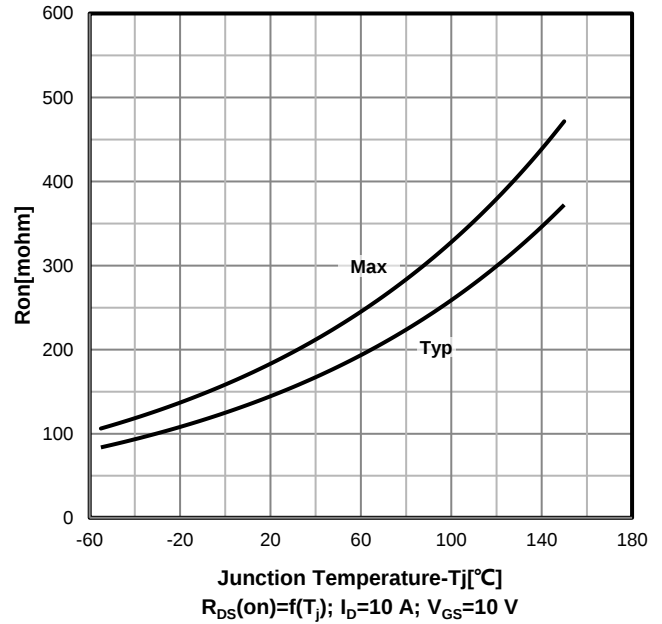


Typical Performance Characteristics

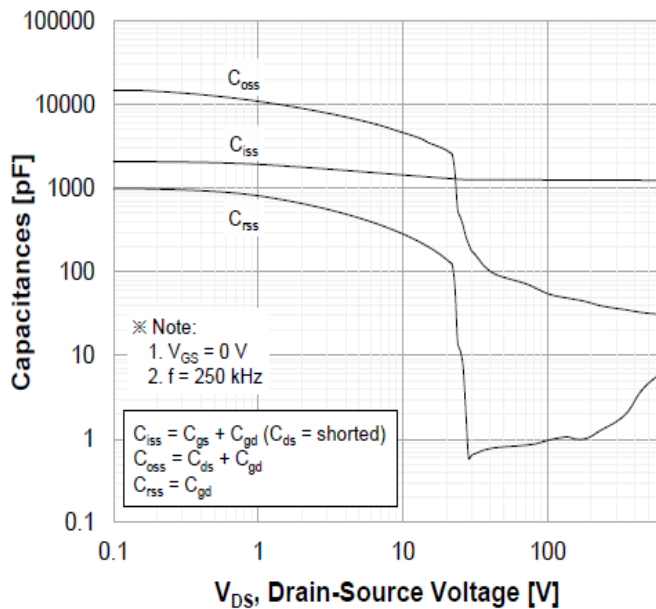
Typ. drain-source on-state resistance



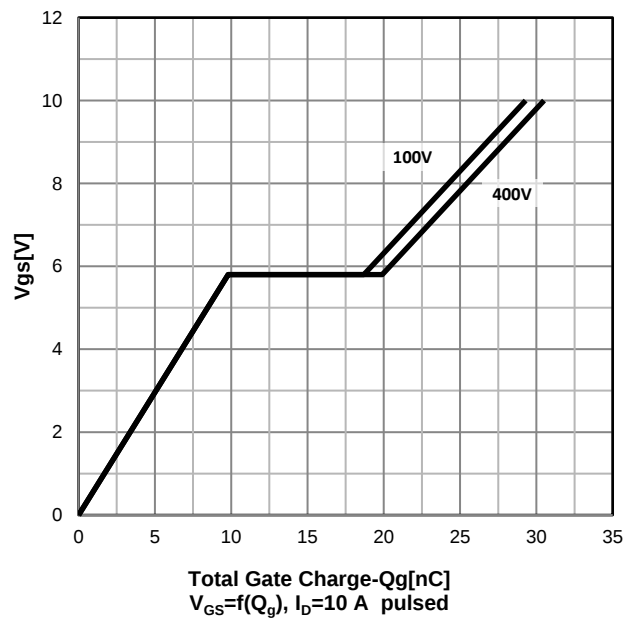
On-resistance vs temperature



Typ. capacitances

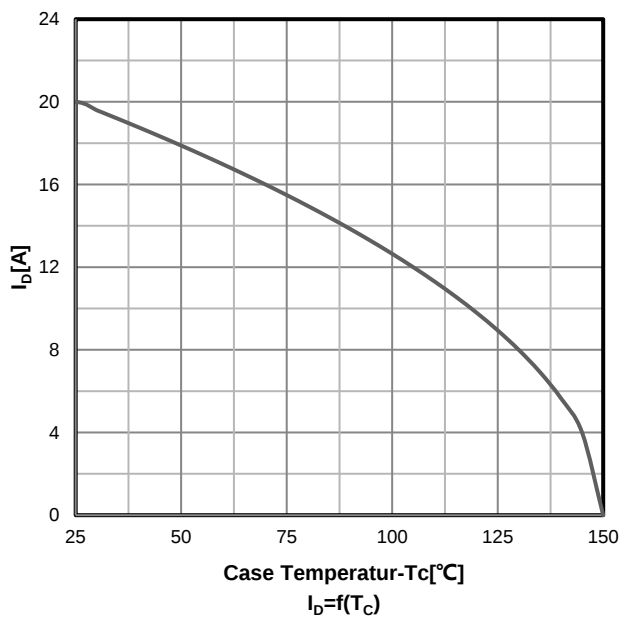


Typ. gate charge characteristics

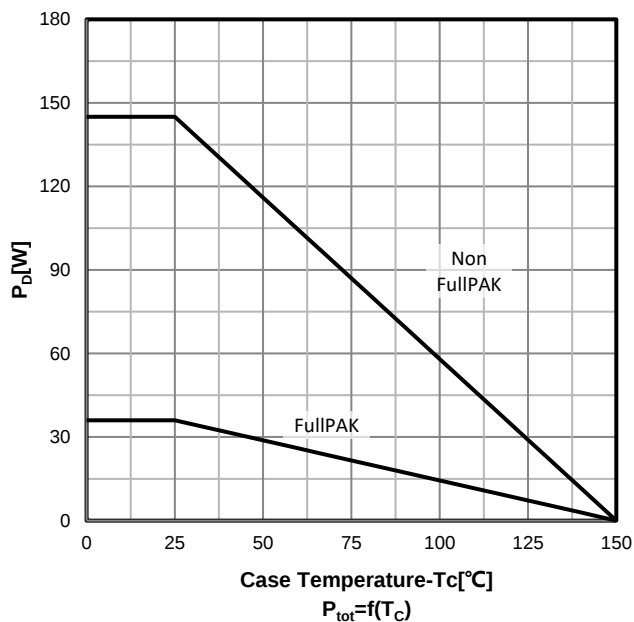


Typical Performance Characteristics

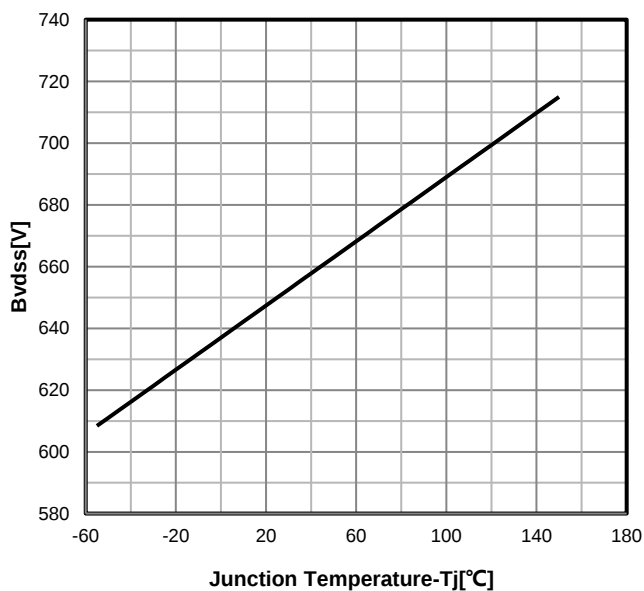
Drain current vs temperature



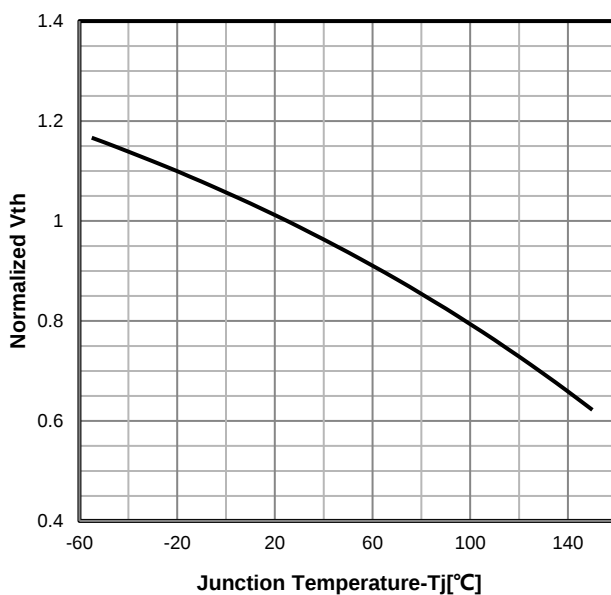
Power dissipation



Drain-source breakdown voltage

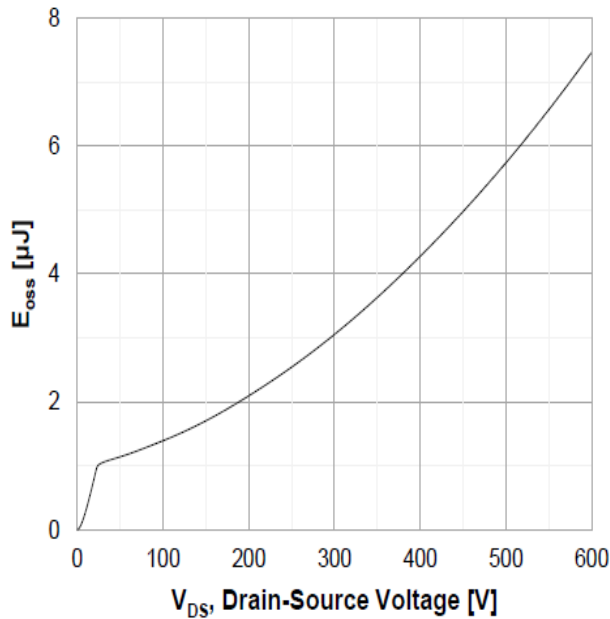


Normalized V_{GS(th)} characteristics

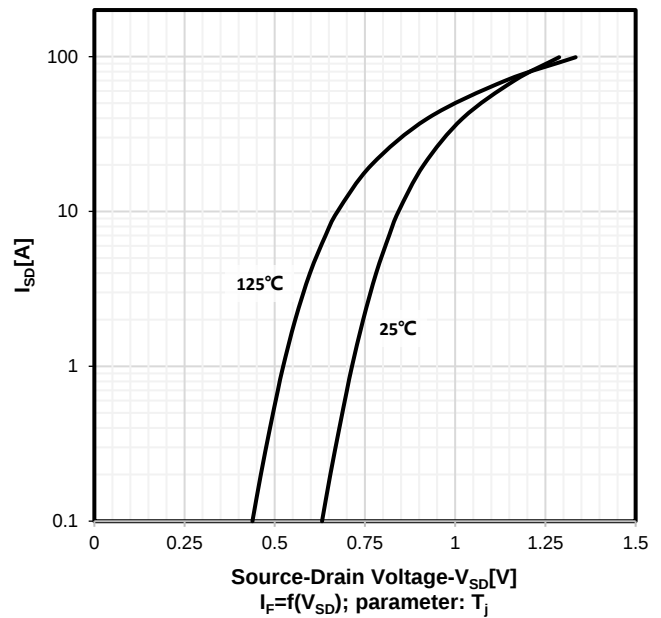


Typical Performance Characteristics

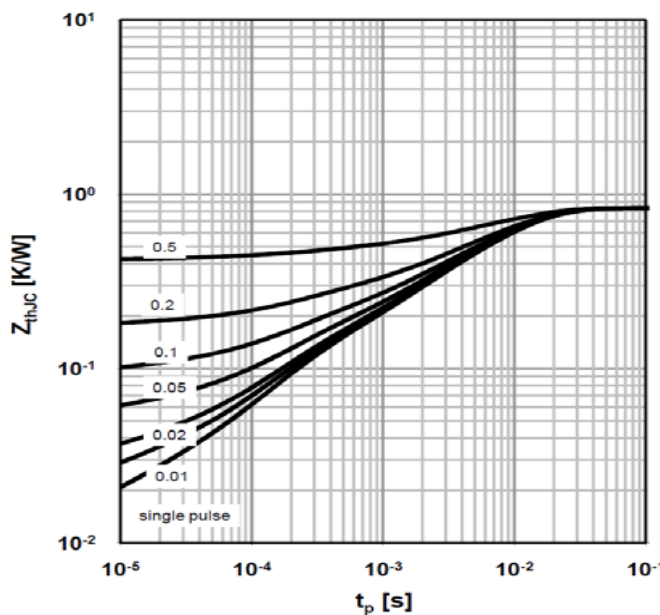
Coss stored energy



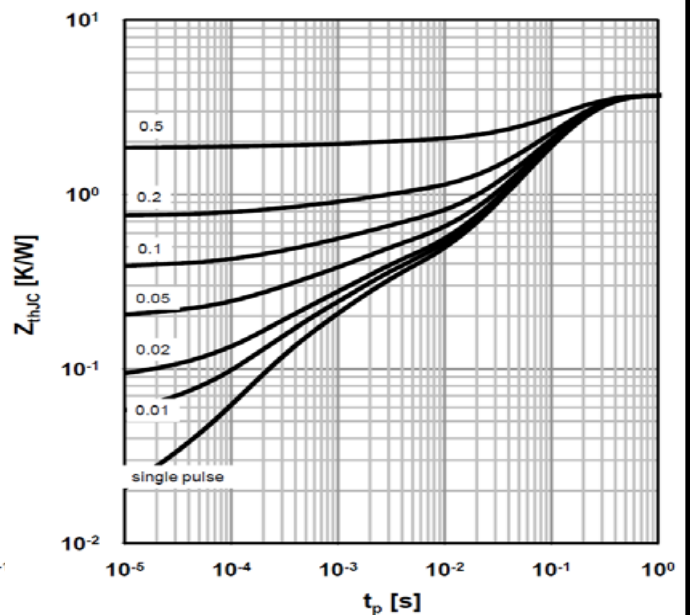
Forward characteristics of reverse diode



Max. transient thermal impedance
TO-220

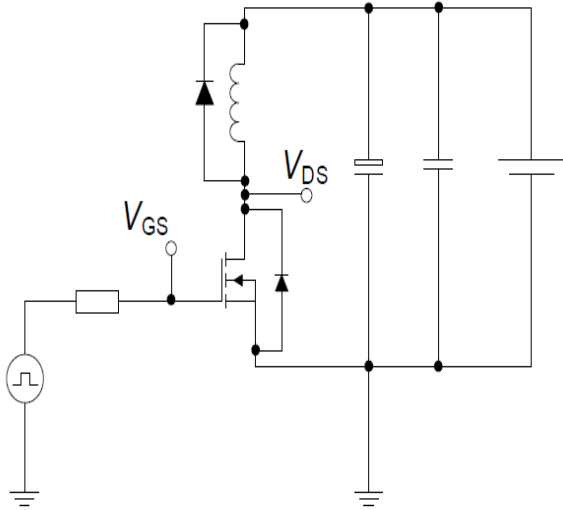


Max. transient thermal impedance
TO-220FullPAK

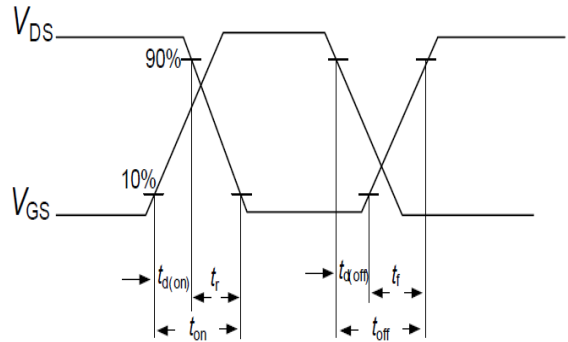


Switching times test circuit and waveform for inductive load

Switching times test circuit for inductive load

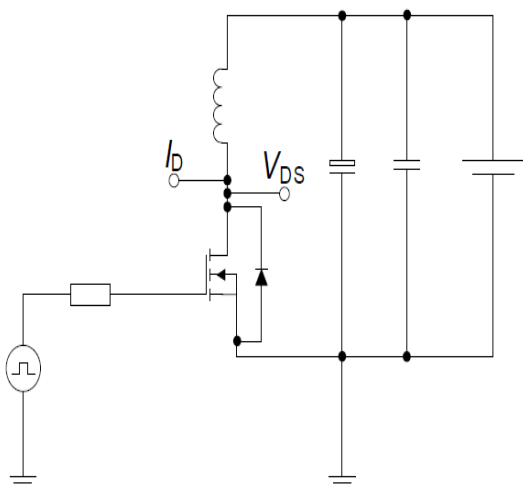


Switching time waveform

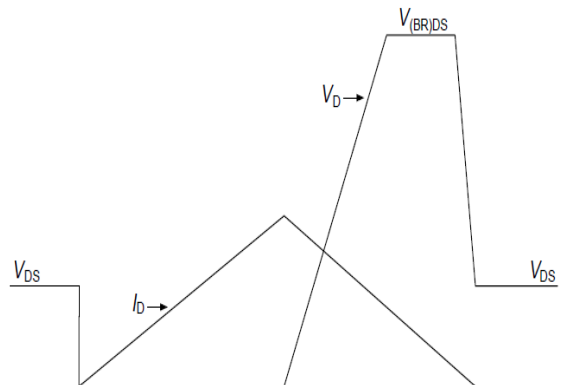


Unclamped inductive load test circuit and waveform

Unclamped inductive load test circuit

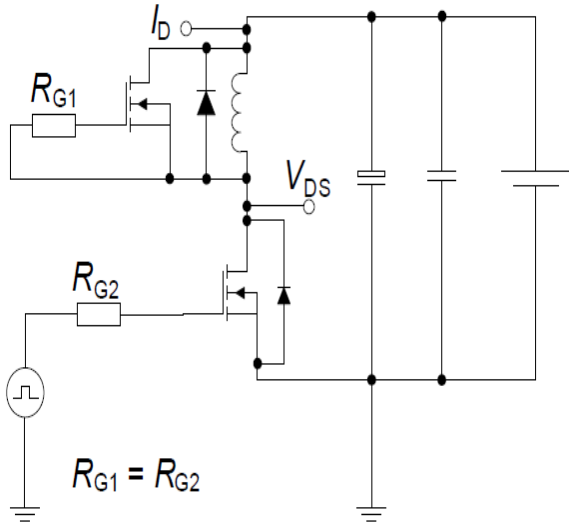


Unclamped inductive waveform

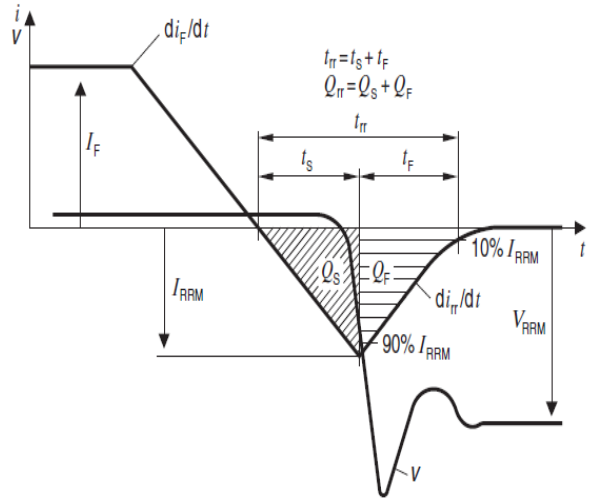


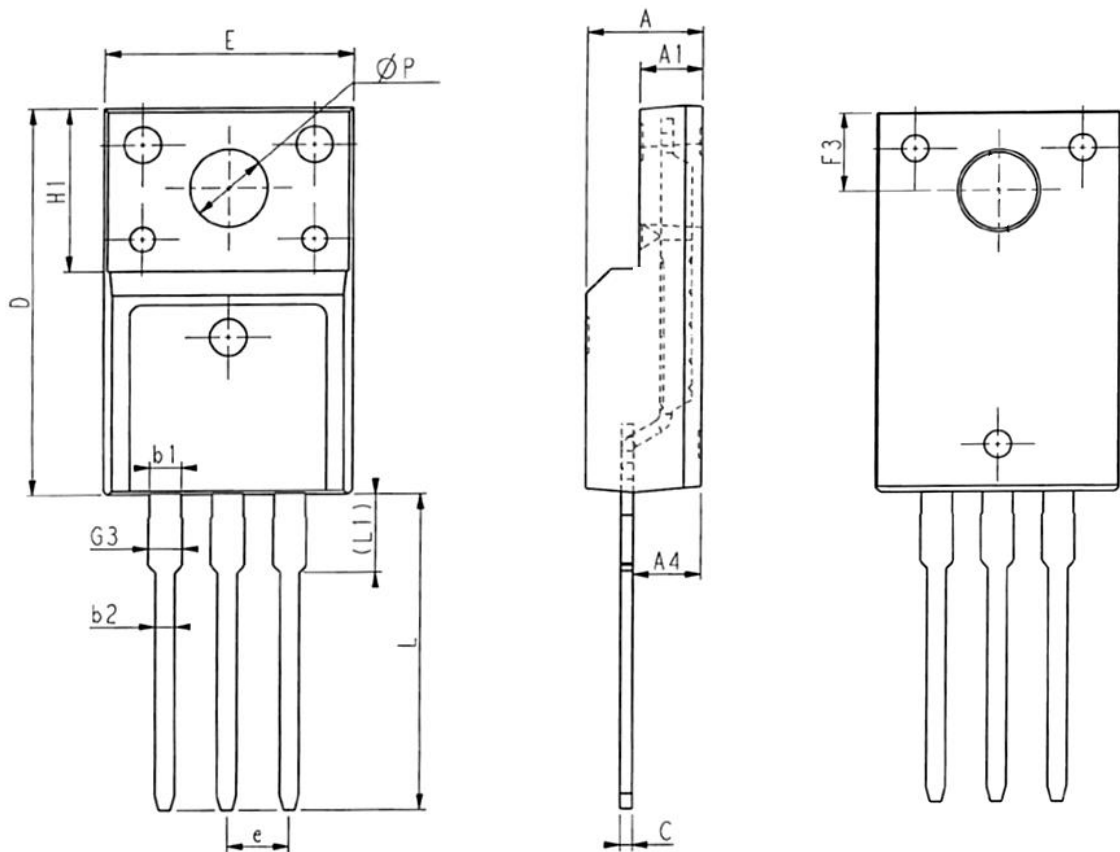
Test circuit and waveform for diode characteristics

Test circuit for diode characteristics



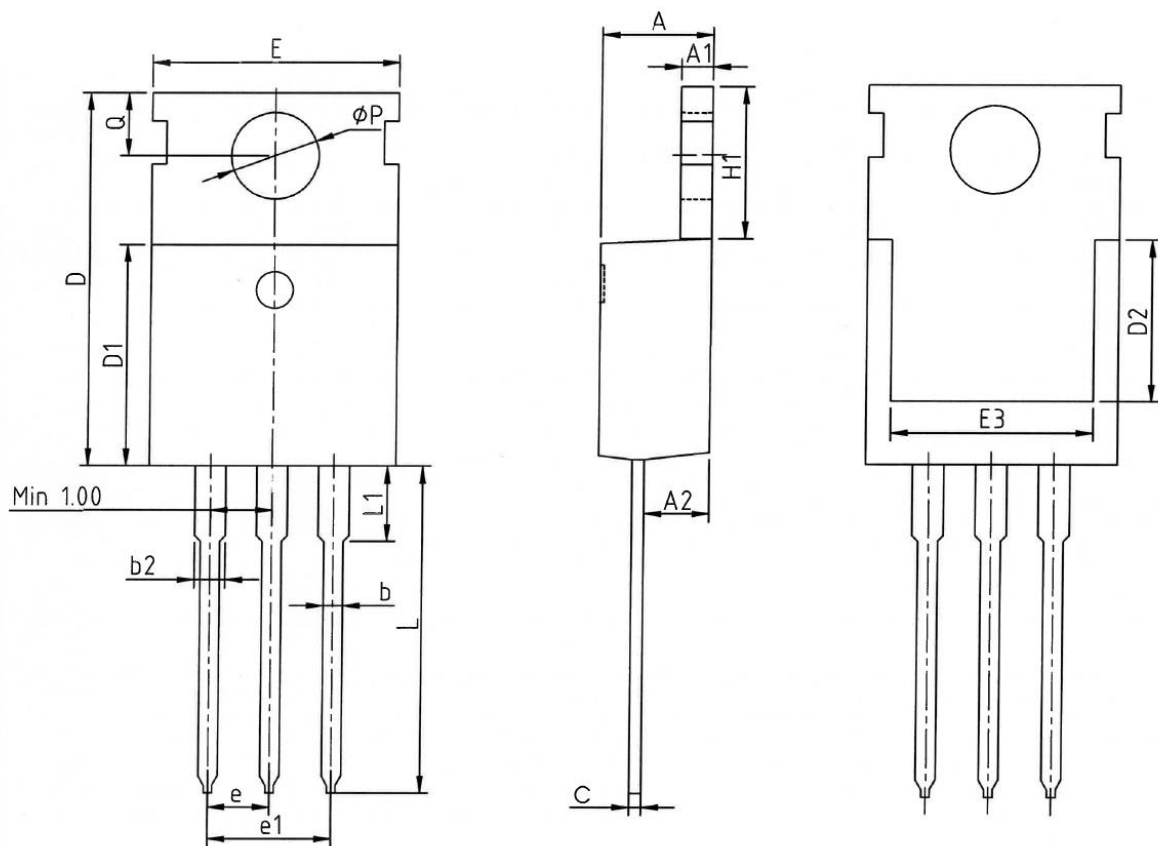
Diode recovery waveform





COMMON DIMENSIONS

SYMBOL	UNIT(mm)		
	MIN	NOM	MAX
E	9.86	10.16	10.36
A	4.50	4.70	4.90
A1	2.34	2.54	2.84
A4	2.56	2.76	2.96
C	0.35	0.50	0.65
D	15.50	15.87	16.25
H1	6.70REF		
e	2.54BSC		
L	12.60	12.98	13.35
L1	3.03	3.23	3.43
ΦP	3.00	3.20	3.40
F3	3.10	3.30	3.50
G3	1.20	1.35	1.60
b1	1.18	1.28	1.43
b2	0.70	0.80	0.95



COMMON DIMENIONS

SYMBOL	MIN	NOM	MAX
A	4.37	4.57	4.70
A1	1.25	1.30	1.40
A2	2.20	2.40	2.60
b	0.70	0.80	0.95
b2	1.17	1.27	1.47
c	0.45	0.50	0.60
D	15.10	15.60	16.10
D1	8.80	9.10	9.40
D2	5.50	6.30	7.10
E	9.70	10.00	10.30
E3	7.00	7.80	8.60
e	2.54 BSC		
e1	5.08 BSC		
H1	6.25	6.50	6.85
L	12.75	13.50	13.80
L1	-	3.10	3.40
ΦP	3.40	3.60	3.80
Q	2.60	2.80	3.00



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